


<b>Search Notes</b>  	<b>Application/Control No.</b>  10551710	<b>Applicant(s)/Patent Under Reexamination</b>  CONDE ET AL.
	<b>Examiner</b>  Bruck Kifle	<b>Art Unit</b>  1624

SEARCHED			
Class	Subclass	Date	Examiner
560	29, 53, 54, 60	12/20/07	BK
562	470	12/20/07	BK
540	524	12/20/07	BK

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
560	29, 53, 54, 60	12/20/07	BK
562	470	12/20/07	BK
540	524	12/20/07	BK